

March 1990 Revised August 1999

### 74F794

## 8-Bit Register with Readback

#### **General Description**

The 74F794 is an 8-bit register with readback capability designed to store data as well as read the register information back onto the data bus. The I/O bus (D bus) has 3-STATE outputs. Current sinking capability is 64 mA on both the D and Q busses.

Data is loaded into the registers on the LOW-to-HIGH transition of the clock (CP). The output enable  $(\overline{OE})$  is used to enable data on  $D_0-D_7$ . When  $\overline{OE}$  is LOW, the output of the registers is enabled on  $D_0-D_7$ , enabling D as an output bus. When OE is HIGH,  $D_0-D_7$  are inputs to the registers configuring D as an input bus.

#### **Features**

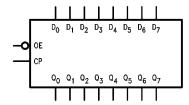
- 3-STATE outputs on the I/O port
- D and Q output sink capability of 64 mA
- Functionally and pin equivalent to the 74LS794

### **Ordering Code:**

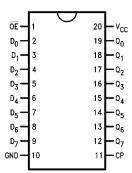
Order Number	Package Number	Package Description
74F794SC	J.	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F794PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP) JEDEC MS-001 0 300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### **Logic Symbol**



### **Connection Diagram**



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DS010652

# Input Loading/Fan-Out

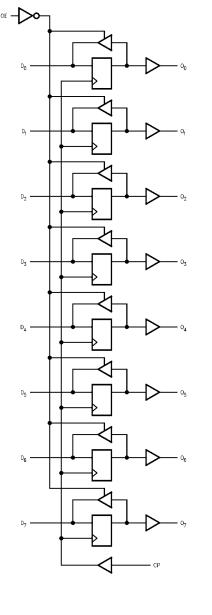
Pin Names	Description	HIGH/LOW			
1 III Ivailles	Description	(U.L.) Current 1.0/1.0 20 μA/–0.6 mA 1.0/1.0 20 μA/–0.6 mA 3.5/1.083 70 μA/–650 μA			
ŌE	Output Enable Input	1.0/1.0	20 μA/-0.6 mA		
CP	Clock Pulse Inputs	1.0/1.0	20 μA/–0.6 mA		
D <sub>0</sub> –D <sub>7</sub>	D Bus Inputs/	3.5/1.083	70 μΑ/–650 μΑ		
	3-STATE Outputs	750/106.6	–15 mA/64 mA		
$Q_0-Q_7$	Q Bus Outputs	750/106.6	–15 mA/64 mA		

### **Truth Table**

Inputs		Outputs			
CP O		ø	D		
L or H or ↓	L	$Q_n$	Output, Q		
L or H or $\downarrow$	Н	$Q_n$	Input		
<b>↑</b>	L	$Q_n$	Output, Q (Note 1)		
1	Н	D	Input		

Note 1: In this case the output of the register is clocked to the inputs and the overall Q output is unchanged at Q<sub>n</sub>.

# Logic Diagram



### **Absolute Maximum Ratings**(Note 2)

**Recommended Operating Conditions** 

Storage Temperature -65°C to + 150°C -55° to +125°C Ambient Temperature under Bias

Junction Temperature under Bias  $-55^{\circ}C$  to  $+150^{\circ}C$ V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0VInput Voltage (Note 3) -0.5V to +7.0V

Input Current (Note 3) -30 mA to +5.0 mA ESD Last Passing Voltage (Min) 4000V

Voltage Applied to Output

In HIGH State (with  $V_{CC} = 0V$ )

Standard Output 3-STATE Output

Current Applied to Output

in LOW State (Max)

Free Air Ambient Temperature 0°C to 70°C Supply Voltage +4.5V to +5.5V

Note 2: Absolute maximum ratings are values beyond which the device -0.5V to V<sub>CC</sub> may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

-0.5 V to +5.5 V Note 3: In this case the output of the register is clocked to the inputs and the overall Q output is unchanged at Qn.

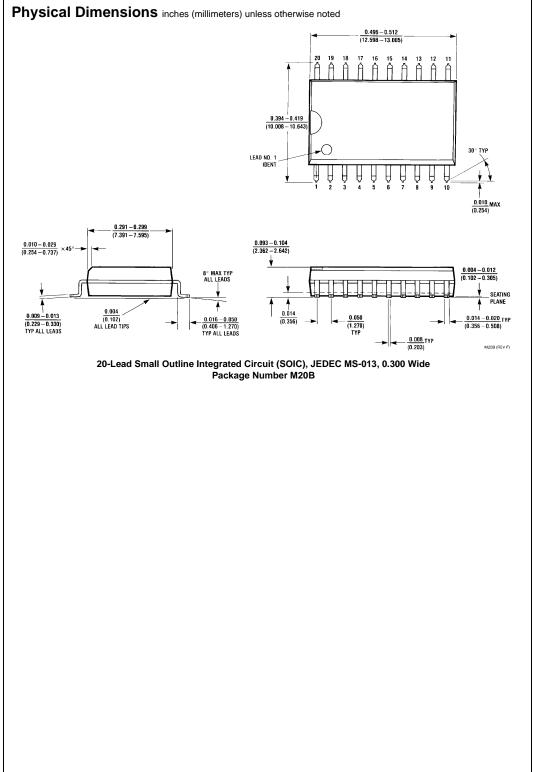
Twice the Rated I<sub>OL</sub> (mA) Note 4: Either voltage limit or current limit is sufficient to protect inputs.

### DC Electrical Characteristics over Operating Temperature Range unless otherwise specified

Symbol	Parameter	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	٧	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage	2.4 2.0	2.8 2.44		V	Min	$I_{OH} = -3 \text{ mA}$ $I_{OH} = -15 \text{ mA}$
V <sub>OL</sub>	Output LOW Voltage		0.45	0.55	V	Min	I <sub>OL</sub> = 64 mA
I <sub>IH</sub>	Input HIGH Current			5.0	μА	Max	V <sub>IN</sub> = 2.7V
I <sub>BVI</sub>	Input HIGH Current Breakdown Test			7.0	μА	Max	$V_{IN} = 7.0V (\overline{OE}, CP)$
I <sub>BVIT</sub>	Input HIGH Current Breakdown (I/O)			0.5	mA	Max	$V_{IN} = 5.5V (D_n)$
I <sub>CEX</sub>	Output HIGH Leakage Current			50	μА	Max	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu A$ All Other Pins Grounded
I <sub>OD</sub>	Output Leakage Circuit Current			3.75	μА	0.0	V <sub>IOD</sub> = 150 mV All Other Pins Grounded
I <sub>IL</sub>	Input LOW Current			-0.6	mA	Max	$V_{IN} = 0.5V$ (OE, CP)
I <sub>OS</sub>	Output Short- Circuit Current	-100		-225	mA	Max	V <sub>OUT</sub> = 0V
I <sub>IH</sub> + I <sub>OZH</sub>	Output Leakage Current			70	μА	Max	V <sub>OUT</sub> = 2.7V (Dn)
I <sub>IL</sub> + I <sub>OZL</sub>	Output Leakage Current			-650	μА	Max	V <sub>OUT</sub> = 0.5V (Dn)
V <sub>ID</sub>	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu A$ All Other Pins Grounded
I <sub>OD</sub>	Output Circuit Leakage Current			3.75	μА	0.0	V <sub>IOD</sub> = 150 mV All Other Pins Grounded
I <sub>ZZ</sub>	Bus Drainage Test			100	μΑ	0.0	V <sub>OUT</sub> = 5.25V
I <sub>CCH</sub>	Power Supply Current			65	mA	Max	V <sub>O</sub> = HIGH
I <sub>CCL</sub>	Power Supply Current			80	mA	Max	$V_O = LOW$
I <sub>CCZ</sub>	Power Supply Current			80	mA	Max	V <sub>O</sub> = HIGH Z

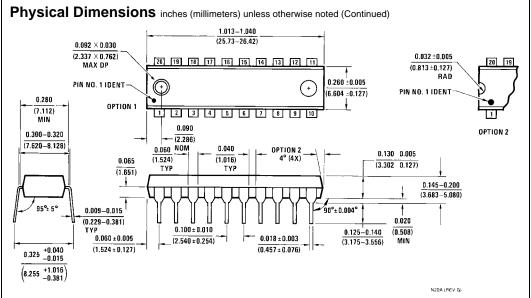
## **AC Electrical Characteristics**

Symbol	Parameter	$T_A = +25^{\circ}\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		Units	
		Min	Тур	Max	Min	Max		
f <sub>MAX</sub>	Maximum Clock Frequency	90			90		MHz	
t <sub>PLH</sub>	Propagation Delay	2.5		7.0	2.5	8.0	ns	
t <sub>PHL</sub>	CP to Q <sub>n</sub>	2.5		8.0	2.5	9.0		
t <sub>PZH</sub>	Output Enable Time	2.3		8.5	2.0	9.0	ns	
t <sub>PZL</sub>		2.0		10.0	2.0	10.5		
t <sub>PHZ</sub>	Output Disable Time	1.0		7.0	1.0	8.0	ns	
t <sub>PLZ</sub>		1.0		7.0	1.0	8.0	115	
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	4.0			4.0			
t <sub>S</sub> (L)	Bus to Clock	4.0			4.0		ns	
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	1.5			1.5			
t <sub>H</sub> (L)	Bus to Clock	1.5			1.5		ns	
t <sub>W</sub> (H	Clock Pulse Width	5.8			5.8		ns	
	HIGH or LOW	5.8			5.8			



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20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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